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Errata to IEEE Standard for the Preparation of Test Procedures for the Thermal Evaluation of Solid Electrical Insulating Materials

Sponsor

Standards Coordinating Committee 4 on Thermal Rating

of the

IEEE Electrical Insulation Society

Correction Sheet

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Page 15, NOTE 2 to Table B.1—Suggested exposure temperatures and times, should be changed to read as follows:

2—When extending the test program by submitting additional specimens to aging at temperatures below the lower of the originally planned aging temperatures, a temperature interval of 10 °C and a cycle duration of 42 days for TI/RTI determination should be considered.